

1. **DESCRIPTION**

The XD/ XL3085 is a +5V, half-duplex, ±15KV ESD protected RS485/RS-422 transceiver circuit. The circuit contains one driver and one receiver.

The XD/XL3085 is a half-duplex type with drive enable (DE) and receive enable E()R pins, and the drive and receive outputs are high-impedance when in the off state.

The XD/XL3085 has a failsafe circuit to ensure that the receiver output is correct when the receiver input is open or shorted.

The XD/XL3085 receiver input impedance is 1/8 unit load, allowing up to 256 transceivers to be hooked up to the bus.

2. FEATURES

- Electrostatic Protection (ESD): L1/L2 ±15KV Human Body Mode (HBM)
- bus allows up to 256 transceivers to be hooked up
- Strong swing rate limiting helps achieve error-free data transmission
- Tri-state outputs
- DIP8/SOP8 package
- Complies with Q/GDW 11179.11-2015 Technical Specification for Components for Energy Meters



3. PIN CONFIGURATIONS and FUNCTIONS



Pin Functions

Pin	Name	Description
1	RO	Receive Output
2	RE	Receive enable terminal: active low, when DE is high, the receive output is high resistance.
3	DE	Transmit Enable: active high, when DE is low, transmit output is high resistance. DE
4	DI	When DE is high, the chip operates in transmit state, when DE is low and low level, the chip operates in receive state.
5	GND	Transmit Data Input
6	L1	Ground
7	L2	Receive Input/Transmit Output
8	Vcc	Receive Input/Transmit Output



4. Logical relationships

4.1. No polarity XD/XL3085 chip driver truth table

Input	Enable	Output						
DI	DE	А	В					
Active state								
н	н	н	L					
L	н	L	н					
x	L	Z	Z					
	Reven	se state						
н	н	L	н					
L	н	н	L					
x	L	Z	Z					

4.2. No polarity XD/XL3085 chip receiver truth table

Input			Output
RE	DE	АХВ	RO
L	x	>100mV	н
L	x	<-100mV	L for polarity judgement time H (outside polarity judgement time)
L	Х	open circuit	H (outside polarity judgement time)
L	Х	short circuit	H (outside polarity judgement time)
н	н	x	Z
н	L	x	Z



5. SPECIFICATIONS

5.1. Absolute Maximum Ratings

SYMBOL	Supply Voltage	MIN	MAX	UNIT
Vcc	Control input voltage (DE, RE)	-	+6.0	V
	Drive input voltage (DI) -0.5		+6.0	V
	Drive output voltage (L1, L2)	-0.5	+6.0	V
	Receive input voltage (L1, L2)	-7.0	+12.0	V
	Receive output voltage (RO)	-7.0	+12.0	V
	Storage temperature range	orage temperature range -0.3 VCC+0.3		V
TSTG	Operating Temperature Range	-55	+150	°C
Тор	Maximum Operating Temperature Range	-40	+85	°C
Тмор	8-pin moulded DIP (above +70°C)	-55	+125	°C
Continuous power	8-pin moulded SOP (above +70°C)	-	725	mW
consumption	Soldering Temperature (10 seconds)	-	470	mW
	Supply Voltage	-	+300	°C



5.2. DC characteristics

(if not specified Vcc=5V±5%, TA=25°C)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	ТҮР	MAX	UNIT		
Operating Voltage Range	Vcc				4.5		5.5	v	
Driver differential output (without load)	VOD1		-		-	-	5	v	
Driver differential output (with load)	VOD2				1.5	-	-	V	
Driver Differential Output Voltage	ΔVOD			-	-	0.2	v		
Amplitude of change (Note 2)	VOC	Ilgure 1,	K=541	2 or K=27Ω	1	-	3	V	
Driver common mode output voltage	Δνος				-	-	0.2	v	
Driver Common Mode Output Voltage	VIH	ſ	DE,RE,	DI	2	-	-	v	
Amplitude of change (Note 2)	VIL	DE, RE, DI		-	-	0.8	v		
Input High Voltage	lin1	DE,RE,DI		-	-	±2	uA		
Input low voltage		DE=0V.	N	/IN=5V	-	40	90		
Input current	IIN2	Vcc=5V	١	/IN=0V	-	60	100	UA	
Input current (L1,L2) (Note 3)	VTH	-7V ≤ V _{CM} ≤+12V		-100	-	100	mV		
Receiver differential input threshold voltage	Δντη			-	25	-	mV		
Receiver input hysteresis	VOH	I	IO=-8m	hΑ	4	-	-	v	
Receiver output high	VOL		IO=8m	A	-	-	0.4	v	
Receiver output low level	IOZR	0.4	V ≤Vo≤	2.4V	-	-	1	uA	
Receiver terminal tri-state (high resistance) output current	RIN	-7V ≤VCM≤+12V		96	-	-	kΩ		
Receiver Input Impedance	100	unloaded	l,	DE = Vcc	-	480	600	uA	
No Load Supply Current		RE=DI=GI or Vcc	ND	DE=GND	-	450	600	uA	
Receiver output short-circuit current	IOSR	0V ≤VRO≤VCC		-	-	95	mA		
ESD Protection		L1, L2 Pins,	Humar	n Body Mode	±8	±15	-	kV	

[1] All currents flowing into the device are positive and currents flowing out of the device are negative; all voltages are referenced to ground if not otherwise noted.

[2] $$\Delta VOD$ and ΔVOC are the respective changes in VOD and VOC when the DI input state is changed.$

[3] The illustrations shown use L1 as the A port and L2 as the B port, and vice versa. $_{\circ}$



5.3. Switching characteristics

(if not specified Vcc=5V±5%, TA=25°C)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
Drive Innut to Output	tdplh		250	-	1000	nS
	tDPHL		250	-	1000	nS
Drive Output Offset tDPLH - tDPHL	tdskew	figure 3 and figure 5 RDIFF=50Ω CL1=CL2=100pF	-	-3	±100	nS
Drive Rise Fall Time	tDR		200	-	750	nS
	tDF		200	-	750	nS
Driver enable to output high	tDZH	figure 4 and figure 6,CL=100pF S2 close	-	-	2500	nS
Drive enable to output low	tDZL	figure 4 and figure 6, CL=100pF S1 close	-	-	2500	nS
Drive low to off	tDLZ	figure 4 and figure 6, CL=15pF S1 close	-	-	100	nS
Driver high to off	tDHZ	figure 4 and figure 6, CL=15pF S2 close	-	-	100	nS
Dessiver lanut to Output	tRPLH		-	-	200	nS
	tRPHL	figure 7 and figure 9, VID ≥	-	-	200	nS
Differential Receiver Offset tRPLH - tRPHL	tRSKEW	VID 上升下降时间≤15nS	-	3	±30	nS
Receiver enable to output low	tRZL	figure 2 and figure 8 CL=100pF S1 close	-	20	50	nS
Receiver enable to output high	tRZH	figure 2 and figure 8 CL=100pF S2 close	-	20	50	nS
Receiver low to off	tRLZ	figure 2 and figure 8 CL=100pF S1 close	-	20	50	nS
Receiver high to off	tRHZ	figure 2 and figure 8 CL=100pF S2 close	-	20	50	nS
Driver output short-circuit current	IOD	Short circuit current between L1/L2	-	-	150	mA
Maximum Data Speed	fMAX		250	500	-	Kbps
Communication BER		Communication rate 250kbps	-	-	10 ⁻⁷	-

5.4. Impolar characteristics

The polarity direction of the drive polarity switch and the receive polarity switch remain the same, and the polarity direction changes after a Ts time duration in the following cases DE=RE=OV and RO is low.

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	MAX	UNIT
Infinitely switchable flip-flop wait time	Ts	DE=RE=0,RO is low	10	65	150	ms



5.5. Test line and switch waveforms



figure 1: Driver DC Characterisation Test Load



figure 3: Driver Switching Characteristics Test Load



figure 2: Receiver Enable/Off Switching Characteristics Test Load



figure 4: Driver Enable/Off Switching Characteristics Test Load



figure 5: Drive Transfer Delay





figure 6: Driver Enable/Disable Timing



figure 7: Receiver transmission delay



figure 8: Receiver Enable/Off Timing





figure 9: Receiver Transmission Delay Test Circuit

6. 1.Application information

6.1. Detailed Description

The XD/XL3085 high speed transceiver for RS-485/RS-422 communications consists of a driver and a receiver. The XD/XL3085 high-speed transceiver for RS-485/RS-422 communication consists of a driver and a receiver. It is equipped with a fail-safe circuit that ensures that the receiver output goes logic high when the receiver input is open or shorted. If all transmitters hooked up to the termination matching bus are disabled (high resistance), the receiver will output a logic high. x d/xl3085 has a low-swing driver that reduces EMI and reflections due to improper cable termination, enabling error-free data transmission up to 500 kbps. x d/xl3085 is a half-duplex transceiver.

6.2. Application areas

- Industrial control
- Meters
- Industrial motor drives
- Automatic HVAC systems
- RS485/RS422 interface

6.3. Receiver Input Filtering

When operating the XD/XL3085 in 500kbps mode, the receiver includes an input filter function in addition to input hysteresis. This filtering improves noise rejection of differential signals with slow rise and fall.

6.4. Reducing EMI and reflections

The low-swing drivers of the XD/XL3085 reduce EMI and reflections caused by improperly terminated matching cables.



6.5. Bus-mounted 256 loads

The XD/XL 3085 has a load input impedance greater than $96K\Omega$, allowing up to 256 transceivers to be hooked up to the same communications bus. The communication error rate is less than 10-5 at 2.4kbps and 9.6kbps.

6.6. ESD Protection

All pins of the XD/XL3085 have electrostatic discharge (ESD) protection circuitry to prevent damage to the chip from human touch or ESD events during assembly. The driver's output and receiver's input pins are additionally enhanced with ESD protection circuitry that allows these pins to withstand an ESD shock of ±15kV without damage.

There are many ways to test the ESD protection performance. The outputs of the driver and the inputs of the receiver are measured for ESD performance using the following ESD test method: \pm 15kV human body model.

6.7. Typical Application Diagram



figure 10: XD/XL3085 Typical Half-Duplex Operating Circuits





7. ORDERING INFORMATION

Part Number	Device Marking	Package Type	Body size (mm)	Temperature (°C)	MSL	Transport Media	Package Quantity		
XL3085	XL3085	SOP8	4.90 * 3.90	-40 to +85	MSL3	T&R	2500		
XD3085	XD3085	DIP8	9.25 * 6.38	-40 to +85	MSL3	Tube 50	2000		

Ordering Information

8. DIMENSIONAL DRAWINGS





DIP8				
A3 A2 PIN1				
$ \begin{array}{c c} \hline \\ \hline \\$				
		MIN	NOM	MAX
	A	3.600	3. 800	4.000
	A1	3.786	3.886	3. 986
	A2	3.200	3.300	3.400
	A3	1.550	1.600	1.650
	b	0.440	2 540	0.490
	D D	<u>2.010</u> 9.150	2.040 9.250	<u>2. 570</u> 9.350
	E	7,800	8. 500	9.200
	E1	6.280	6. 380	6. 480
	L	3.000	_	—